MB39C007

# 2 ch DC/DC Converter IC with PFM/PWM Synchronous Rectification 

## Description

The MB39C007 is a current mode type 2-channel DC/DC converter IC built-in voltage detection, synchronous rectifier, and down conversion support. The device is integrated with a switching FET, oscillator, error amplifier, PFM/PWM control circuit, reference voltage source, and voltage detection circuit. The external inductor and de-coupling capacitor are needed only for the external component.MB39C007 is small, achieve a highly effective DC/DC converter in the full load range. This device is suitable as the built-in power supply for handheld equipment such as mobile phones/PDA, DVDs, and HDDs.

## Features

■ High efficiency: $96 \%$ (Max)
■ Low current consumption: $30 \mu \mathrm{~A}$ (At PFM/ch)
■ Output current: $800 \mathrm{~mA} / \mathrm{ch}$ (Max)
■ Input voltage range: 2.5 V to 5.5 V
■ Operating frequency: 2.0 MHz (Typ)
■ Built-in PWM operation fixed function

- No flyback diode needed

■ Low dropout operation: For $100 \%$ on duty
■ Built-in high-precision reference voltage generator: $1.30 \mathrm{~V} \pm 2 \%$
■ Consumption current in shutdown mode: $1 \mu \mathrm{~A}$ or less
■ Built-in switching FET: P-ch MOS $0.3 \Omega$ (Typ), N-ch MOS $0.2 \Omega$ (Typ)
■ High speed for input and load transient response in the current mode
■ Over-temperature protection
■ Packaged in a compact package: QFN-24

## Applications

- Flash ROMs
- MP3 players
- Electronic dictionary devices

■ Surveillance cameras

- Portable GPS navigators

■ DVD drives
■ IP phones
■ Network hubs
■ Mobile phones etc.

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## 1. Pin Assignment

| (Top View)LX2 DGND2 ${ }^{\text {dGND2 }}$ DGND1 DGND1 LX1 |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DVDD2 | 18 | 17 | 16 | 15 | 14 | 13 |  | DVDD1 |
|  | 19 |  |  |  |  |  | 12 |  |
| DVDD2 | 20 |  |  |  |  |  | 11 | DVDD1 |
| OUT2 | 21 |  |  |  |  |  | 10 | OUT1 |
| MODE2 | 22 |  |  |  |  |  | 9 | MODE1 |
| VREFIN2 | 23 |  |  |  |  |  | 8 | VREFIN1 |
| XPOR | 24 |  |  |  |  |  | 7 | VDET |
|  | 1 | 2 | 3 | 4 | 5 | 6 |  |  |
| CTLP CTL2 CTL1 AGND AVDD VREF |  |  |  |  |  |  |  |  |
| (WNN024) |  |  |  |  |  |  |  |  |

## 2. Pin Descriptions

| Pin No. | Pin Name | I/O | Description |
| :---: | :---: | :---: | :--- |
| 1 | CTLP | I | Voltage detection circuit block control input pin. <br> (L: Voltage detection function stop $, \mathrm{H}:$ Normal operation) |
| 2,3 | CTL2, CTL1 | I | DC/DC converter block control input pins. <br> (L: Shut down , H : Normal operation) |
| 4 | AGND | - | Control block ground pin. |
| 5 | AVDD | - | Control block power supply pin. |
| 6 | VREF | O | Reference voltage output pin. |
| 7 | VDET | I | Voltage detection input pin. |
| 8,23 | VREFIN1, VREFIN2 | I | Error amplifier (Error Amp) non-inverted input pins. |
| 9,22 | MODE1, MODE2 | I | Operation mode switch pins. <br> (L: PFM/PWM mode , OPEN : PWM mode) |
| 10,21 | OUT1, OUT2 | I | Output voltage feedback pins. |
| 11,12 | DVDD1 | - | Drive block power supply pins. |
| 19,20 | DVDD2 | LX1, LX2 | O |
| 13,18 | Inductor connection output pins. <br> High impedance during shut down. |  |  |
| 14,15 | DGND1 | - | Drive block ground pins. |
| 16,17 | DGND2 | XPOR | O |
| 24 | VDET circuit output pin. <br> Connected to an N-ch MOS open drain circuit. |  |  |

## 3. I/O Pin Equivalent Circuit Diagram


4. Block Diagram


### 4.1 Current Mode

■ Original voltage mode type : Stabilize the output voltage by comparing two items below and on-duty control.
a Voltage $\left(\mathrm{V}_{\mathrm{C}}\right)$ obtained through negative feedback of the output voltage by Error Amp
口 Reference triangular wave $\left(\mathrm{V}_{\text {TRI }}\right)$

- Current mode type : Instead of the triangular wave ( $\mathrm{V}_{\mathrm{TRI}}$ ), the voltage ( $\mathrm{V}_{\text {IDET }}$ ) obtained through I-V conversion of the sum of currents that flow in the oscillator (rectangular wave generation circuit) and SW FET is used. Stabilize the output voltage by comparing two items below and on-duty control.
$\square$ Voltage $\left(\mathrm{V}_{\mathrm{C}}\right)$ obtained through negative feedback of the output voltage by Error Amp
$\square$ Voltage ( $\mathrm{V}_{\mathrm{IDET}}$ ) obtained through I-V conversion of the sum of current that flow in the oscillator (rectangular wave generation circuit) and SW FET

Voltage mode type model


Current mode type model


Note : The above models illustrate the general operation and an actual operation will be preferred in the IC.

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## 5. Function of Each Block

## ■ PFM/PWM Logic control circuit

In normal operation, frequency ( 2.0 MHz ) which is set by the built-in oscillator (square wave oscillation circuit) controls the built-in P-ch MOS FET and N-ch MOS FET for the synchronous rectification operation. In the light load mode, the intermittent (PFM) operation is executed.
This circuit protects against pass-through current caused by synchronous rectification and against reverse current caused in a non-successive operation mode.

- I OUT Comparator circuit

This circuit detects the current ( $l_{L X}$ ) which flows to the external inductor from the built-in P-ch MOS FET. By comparing $V_{\text {IDET }}$ obtained through I-V conversion of peak current $\mathrm{I}_{\mathrm{PK}}$ of $\mathrm{I}_{L X}$ with the Error Amp output, the built-in P-ch MOS FET is turned off via the PFM/PWM Logic Control circuit.

- Error Amp phase compensation circuit

This circuit compares the output voltage to reference voltages such as VREF. This IC has a built-in phase compensation circuit that is designed to optimize the operation of this IC.
This needs neither to be considered nor addition of a phase compensation circuit and an external phase compensation device.

- VREF circuit

A high accuracy reference voltage is generated with BGR (bandgap reference) circuit. The output voltage is 1.30 V (Typ).

■ Voltage Detection (VDET) circuit
The voltage detection circuit monitors the VDET pin voltage. Normally, use the XPOR pin through pull-up with an external resistor. When the VDET pin voltage reaches 0.6 V , it reaches the H level.

Timing chart example : (XPOR pin pulled up to $\mathrm{V}_{\mathrm{IN}}$ )


- Protection circuit

This IC has a built-in over-temperature protection circuit. The over-temperature protection circuit turns off both N -ch and P -ch switching FETs when the junction temperature reaches $+135^{\circ} \mathrm{C}$. When the junction temperature comes down to $+110^{\circ} \mathrm{C}$, the switching FET is returned to the normal operation. Since the PFM/PWM control circuit of this IC is in the control method in current mode, the current peak value is also monitored and controlled as required.

| Input |  |  |  | Output |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CTL1 | CTL2 | CTLP | MODE | CH1 function | CH2 <br> function | VDET function | VREF function | Switching operation |
| L |  |  | [1] | Stopped |  |  |  |  |
| H | L | L | L | Operation | Stopped | Stopped | 1.3 V output | PFM/PWM mode |
| L | H |  |  | Stopped | Operation |  |  |  |
| H |  |  |  | Operation |  |  |  |  |
| L |  | H |  | Stopped |  | Operation |  |  |
| H | L |  |  | Operation | Stopped |  |  |  |
| L | H |  |  | Stopped | Operation |  |  |  |
| H |  |  |  | Operation |  |  |  |  |
| H | L | L | Open | Operation | Stopped | Stopped |  | PWM fixed mode |
| L | H |  |  | Stopped | Operation |  |  |  |
| H |  |  |  |  |  |  |  |  |
| L |  | H |  | Stopped |  | Operation |  |  |
| H | L |  |  | Operation | Stopped |  |  |  |
| L | H |  |  | Stopped | Operation |  |  |  |
| H |  |  |  | Operation |  |  |  |  |

## 6. Absolute Maximum Ratings

| Parameter | Symbol | Condition | Rating |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Max |  |
| Power supply voltage | $V_{D D}$ | AVDD = DVDD1 = DVDD2 | -0.3 | +6.0 | V |
| Signal input voltage | $\mathrm{V}_{\text {ISIG }}$ | OUT1, OUT2 pins | -0.3 | $V_{D D}+0.3$ | V |
|  |  | CTLP, CTL1, CTL2, MODE1, MODE2 pins | -0.3 | $V_{D D}+0.3$ |  |
|  |  | VREFIN1, VREFIN2 pins | -0.3 | $V_{D D}+0.3$ |  |
|  |  | VDET pin | -0.3 | $\mathrm{V}_{\mathrm{DD}}+0.3$ |  |
| XPOR pull-up voltage | $\mathrm{V}_{\text {IXPOR }}$ | XPOR pin | -0.3 | +6.0 | V |
| LX voltage | $V_{\text {LX }}$ | LX1, LX2 pins | -0.3 | $V_{D D}+0.3$ | V |
| LX Peak current | lpK | The upper limit value of $\mathrm{I}_{\mathrm{LX} 1}$ and ${ }^{\text {LXX2 }}$ | - | 1.8 | A |
| Power dissipation | $\mathrm{P}_{\mathrm{D}}$ | $\mathrm{Ta} \leq+25^{\circ} \mathrm{C}$ | - | $3125^{[1],[2],[3]}$ | mW |
|  |  |  | - | $1563{ }^{[1],[2],[4]}$ |  |
|  |  | $\mathrm{Ta}=+85^{\circ} \mathrm{C}$ | - | $1250{ }^{[1],[2],[3]}$ | mW |
|  |  |  | - | $625^{[1],[2],[4]}$ |  |
| Operating ambient temperature | Ta | - | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature | $\mathrm{T}_{\text {STG }}$ | - | -55 | +125 | ${ }^{\circ} \mathrm{C}$ |

[1] : See the diagram of "Example of Standard Operation Characteristics". Power dissipation vs. Operating ambient temperature for the package power dissipation of Ta from $+25^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.
[2] : When mounted on a four-layer epoxy board of $11.7 \mathrm{~cm} \times 8.4 \mathrm{~cm}$
[3] : C is mounted on a four-layer epoxy board, which has thermal via, and the IC's thermal pad is connected to the epoxy board (Thermal via is 9 holes)
[4] : IC is mounted on a four-layer epoxy board, which has no thermal via, and the IC's thermal pad is connected to the epoxy board.

## Notes:

■ The use of negative voltages below -0.3 V to the AGND , DGND 1 , and DGND2 pin may create parasitic transistors on LS lines, which can cause abnormal operation.

- This device can be damaged if the LX1 pin and LX2 pin are short-circuited to AVDD and DVDD1/DVDD2, or AGND and DGND1/DGND2.
WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.


## 7. Recommended Operating Conditions

| Parameter | Symbol | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| Power supply voltage | $V_{D D}$ | AVDD = DVDD1 = DVDD2 | 2.5 | 3.7 | 5.5 | V |
| VREFIN voltage | $V_{\text {REFIN }}$ | - | 0.15 | - | 1.30 | V |
| CTL voltage | $\mathrm{V}_{\text {CTL }}$ | CTLP, CTL1, CTL2 pins | 0 | - | 5.0 | V |
| LX current | ILX | $\mathrm{L}_{\text {LX1 }}, \mathrm{I}_{\text {LX } 2}$ | - | - | 800 | mA |
| VREF output current | $\mathrm{I}_{\text {ROUT }}$ | $\begin{aligned} & 2.5 \mathrm{~V} \leq \mathrm{AVDD}=\mathrm{DVDD} 1=\mathrm{DVDD} 2< \\ & 3.0 \mathrm{~V} \end{aligned}$ | - | - | 0.5 | mA |
|  |  | $\begin{aligned} & 3.0 \mathrm{~V} \leq \mathrm{AVDD}=\mathrm{DVDD} 1=\mathrm{DVDD} 2 \leq \\ & 5.5 \mathrm{~V} \end{aligned}$ | - | - | 1 |  |
| XPOR current | $\mathrm{I}_{\text {POR }}$ | - | - | - | 1 | mA |
| Inductor value | L | - | - | 2.2 | - | $\mu \mathrm{H}$ |

Note: The output current from this device has a situation to decrease if the power supply voltage $\left(\mathrm{V}_{\mathrm{IN}}\right)$ and the DC/DC converter output voltage ( $\mathrm{V}_{\mathrm{OUT}}$ ) differ only by a small amount. This is a result of slope compensation and will not damage this device.
WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.
Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.
No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

## 8. Electrical Characteristics

$\left(\mathrm{Ta}=+25^{\circ} \mathrm{C}, \mathrm{AVDD}=\mathrm{DVDD} 1=\mathrm{DVDD} 2=3.7 \mathrm{~V}, \mathrm{VOUT} 1 / \mathrm{VOUT} 2\right.$ setting value $\left.=2.5 \mathrm{~V}, \mathrm{MODE} 1 / \mathrm{MODE} 2=0 \mathrm{~V}\right)$

| Parameter |  | Symbol | Pin No. | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min |  |  | Typ | Max |  |
| DC/DC converter block | Input current |  | $\mathrm{I}_{\text {REFIN }}$ | 8,23 | VREFIN $=0.15 \mathrm{~V}$ to 1.3 V | - 100 | 0 | + 100 | nA |
|  | Output voltage | $\mathrm{V}_{\text {OUt }}$ | 10, 21 | $\begin{aligned} & \text { VREFIN }=0.833 \mathrm{~V}, \\ & \text { OUT }=-100 \mathrm{~mA} \end{aligned}$ | 2.45 | 2.50 | 2.55 | V |
|  | Input stability | LINE |  | $\begin{aligned} & 2.5 \mathrm{~V} \leq \mathrm{AVDD}=\mathrm{DVDD} 1=\mathrm{DVDD} 2 \\ & \leq 5.5 \mathrm{~V}^{[2]} \end{aligned}$ | - | - | 10 | mV |
|  | Load stability | LOAD |  | $-100 \mathrm{~mA} \geq$ OUT $\geq-800 \mathrm{~mA}$ | - | - | 10 | mV |
|  | OUT pin input impedance | R out |  | OUT $=2.0 \mathrm{~V}$ | 0.6 | 1.0 | 1.5 | $\mathrm{M} \Omega$ |
|  | LX Peak current | IPK | 13, 18 | Output shorted to GND | 0.9 | 1.2 | 1.7 | A |
|  | PFM/PWM switch current | $\mathrm{I}_{\text {MSW }}$ |  | - | - | 30 | - | mA |
|  | Oscillation frequency | fosc |  | - | 1.6 | 2.0 | 2.4 | MHz |
|  | Rise delay time | ${ }^{\text {tpg }}$ | $\begin{gathered} \hline 2,3, \\ 10,21 \end{gathered}$ | $\begin{aligned} & \hline \mathrm{C} 1 / \mathrm{C} 2=4.7 \mu \mathrm{~F}, \text { OUT }=0 \mathrm{~A}, \\ & \text { OUT1/OUT2 } 0 \rightarrow 90 \% \mathrm{~V}_{\text {OUT }} \end{aligned}$ | - | 45 | 80 | $\mu \mathrm{s}$ |
|  | SW NMOS-FET OFF voltage | $\mathrm{V}_{\text {NOFF }}$ | 13, 18 | - | - | $-10^{[1]}$ | - | mV |
|  | SW PMOS-FET ON resistance | $\mathrm{R}_{\text {ONP }}$ |  | LX1/LX2 $=-100 \mathrm{~mA}$ | - | 0.30 | 0.48 | $\Omega$ |
|  | SW NMOS-FET ON resistance | $\mathrm{R}_{\text {ONN }}$ |  | LX1/LX2 $=-100 \mathrm{~mA}$ | - | 0.20 | 0.42 | $\Omega$ |
|  | LX leak current | $\mathrm{I}_{\text {LEAKM }}$ |  | $0 \leq \mathrm{LX} \leq \mathrm{V}_{\mathrm{DD}}{ }^{[3]}$ | -1.0 | - | + 8.0 | $\mu \mathrm{A}$ |
|  |  | ILEAKH |  | $\mathrm{VDD}=5.5 \mathrm{~V}, 0 \leq \mathrm{LX} \leq \mathrm{V}_{\mathrm{DD}}{ }^{[3]}$ | -2.0 | - | + 16.0 | $\mu \mathrm{A}$ |
| Protection circuit block | Overheating protection (Junction Temp.) | TOTPH | - | - | $+120{ }^{[1]}$ | $+135^{[1]}$ | $+160{ }^{[1]}$ | ${ }^{\circ} \mathrm{C}$ |
|  |  | TOTPL |  |  | $+95{ }^{[1]}$ | $+110^{[1]}$ | $+125^{[1]}$ | ${ }^{\circ} \mathrm{C}$ |
|  | UVLO threshold voltage | $\mathrm{V}_{\text {THHUV }}$ | $\begin{gathered} 5,11, \\ 12,19, \\ 20, \end{gathered}$ | - | 2.17 | 2.30 | 2.43 | V |
|  |  | $\mathrm{V}_{\text {THLUV }}$ |  |  | 2.03 | 2.15 | 2.27 | V |
|  | UVLO hysteresis width | $\mathrm{V}_{\text {HYSUV }}$ |  | - | 0.08 | 0.15 | 0.25 | V |
| Voltage detection circuit block | XPOR threshold voltage | $\mathrm{V}_{\text {THHPR }}$ | 7 | - | 575 | 600 | 625 | mV |
|  |  | $\mathrm{V}_{\text {THLPR }}$ |  |  | 558 | 583 | 608 | mV |
|  | XPOR hysteresis width | $\mathrm{V}_{\text {HYSPR }}$ |  | - | - | 17 | - | mV |
|  | XPOR output voltage | $\mathrm{V}_{\text {OL }}$ | 24 | XPOR $=25 \mu \mathrm{~A}$ | - | - | 0.1 | V |
|  | XPOR output current | $\mathrm{I}_{\mathrm{OH}}$ |  | $\mathrm{XPOR}=5.5 \mathrm{~V}$ | - | - | 1.0 | $\mu \mathrm{A}$ |

[1]: This value is not be specified. This should be used as a reference to support designing the circuits.
$\left(\mathrm{Ta}=+25^{\circ} \mathrm{C}, \mathrm{AVDD}=\mathrm{DVDD} 1=\mathrm{DVDD} 2=3.7 \mathrm{~V}, \mathrm{VOUT} 1 / \mathrm{VOUT} 2\right.$ setting value $\left.=2.5 \mathrm{~V}, \mathrm{MODE} 1 / \mathrm{MODE} 2=0 \mathrm{~V}\right)$

| Parameter |  | Symbol | Pin No. | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min |  |  | Typ | Max |  |
| Control block | CTL threshold voltage |  | $\mathrm{V}_{\text {THHCT }}$ | 1,2,3 | - | 0.55 | 0.95 | 1.45 | V |
|  |  | $\mathrm{V}_{\text {THLCT }}$ | - |  | 0.40 | 0.80 | 1.30 | V |
|  | CTL pin input current | IICTL | $0 \mathrm{~V} \leq \mathrm{CTLP/CTL1/CTL2} \mathrm{\leq 3.7} \mathrm{~V}$ |  | - | - | 1.0 | $\mu \mathrm{A}$ |
| Reference voltage block | VREF voltage | $\mathrm{V}_{\text {REF }}$ | 6 | VREF $=0 \mathrm{~A}$ | 1.274 | 1.300 | 1.326 | V |
|  | VREF Load stability | LoAdREF |  | VREF $=-1.0 \mathrm{~mA}$ | - | - | 20 | mV |
| General | Shut down power supply current | $l_{\text {VDD1 }}$ | $\begin{gathered} 5,11, \\ 12,19, \\ 20 \end{gathered}$ | CTLP/CTL1/CTL2 $=0 \mathrm{~V}$, State of all circuits OFF ${ }^{[4]}$ | - | - | 1.0 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{I}_{\mathrm{VDD1H}}$ |  | ```CTLP/CTL1/CTL2 = 0 V, V V, State of all circuits OFF}\mp@subsup{}{}{[4]``` | - | - | 1.0 | $\mu \mathrm{A}$ |
|  | Power supply current at DC/DC operation 1 (PFM mode) | $\mathrm{I}_{\mathrm{VDD21}}$ |  | 1. $\mathrm{CTLP}=0 \mathrm{~V}, \mathrm{CTL} 1=3.7 \mathrm{~V}$, CTL2 $=0 \mathrm{~V}$ <br> 2. $\mathrm{CTLP}=0 \mathrm{~V}, \mathrm{CTL} 1=0 \mathrm{~V}$, <br> CTL2 $=3.7 \mathrm{~V}, \mathrm{OUT}=0 \mathrm{~A}$ | - | 30 | 48 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{I}_{\text {VDD22 }}$ |  | $\begin{aligned} & \text { CTLP }=0 \mathrm{~V}, \mathrm{CTL} 1 / \mathrm{CTL2}=3.7 \mathrm{~V}, \\ & \mathrm{OUT}=0 \mathrm{~A} \end{aligned}$ | - | 50 | 80 | $\mu \mathrm{A}$ |
|  | Power supply current at DC/DC operation 2 (PWM mode) | ${ }^{\text {V VDD31 }}$ |  | 1. $\mathrm{CTLP}=0 \mathrm{~V}, \mathrm{CTL} 1=3.7 \mathrm{~V}$, <br> CTL2 $=0 \mathrm{~V}$, MODE1/ <br> MODE2 $=$ OPEN <br> 2. $\mathrm{CTLP}=0 \mathrm{~V}, \mathrm{CTL} 1=0 \mathrm{~V}$, CTL2 $=3.7 \mathrm{~V}$, MODE1/ MODE2 $=$ OPEN, OUT $=0 \mathrm{~A}$ | - | 3.5 | 10.0 | mA |
|  |  | ${ }^{\text {V VDD32 }}$ |  | CTLP $=0 \mathrm{~V}, \mathrm{CTL} 1 / \mathrm{CTL2}=3.7 \mathrm{~V}$, MODE1/MODE2 $=$ OPEN, OUT $=0$ A | - | 7.0 | 20.0 | mA |
|  | Power supply current (voltage detection mode) | $I_{\text {VDD5 }}$ |  | $\begin{aligned} & \text { CTLP }=3.7 \mathrm{~V}, \\ & \text { CTL1/CTL2 }=0 \mathrm{~V} \end{aligned}$ | - | 15 | 24 | $\mu \mathrm{A}$ |
|  | Power-on invalid current | $I_{\text {VDD }}$ |  | 1. $\mathrm{CTL} 1=3.7 \mathrm{~V}, \mathrm{CTL} 2=0 \mathrm{~V}$ <br> 2. $\mathrm{CTL} 1=0 \mathrm{~V}, \mathrm{CTL2}=3.7 \mathrm{~V}$, VOUT1/VOUT2 $=90 \%$, OUT $=0 A^{[5]}$ | - | 1000 | 2000 | $\mu \mathrm{A}$ |

[2] : The minimum value of AVDD = DVDD1 = DVDD2 is the 2.5 V or $\mathrm{V}_{\mathrm{OUT}}$ setting value +0.6 V , whichever is higher.
[3] : The + leak at the LX1 pin and LX2 pin includes the current of the internal circuit.
[4] : Sum of the current flowing into the AVDD, the DVDD1, and the DVDD2 pins.
[5] : Current consumption based on $100 \%$ ON-duty (High side FET in full ON state). The SW FET gate drive current is not included because the device is in full ON state (no switching operation). Also the load current is not included.

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## 9. Test Circuit for Measuring Typical Operating Characteristics



| Component | Specification | Vendor | Part Number | Remarks |
| :---: | :---: | :---: | :---: | :---: |
| R1 | $1 \mathrm{M} \Omega$ | KOA | RK73G1JTTD D 1 M $\Omega$ |  |
| R3-1 | $20 \mathrm{k} \Omega$ | SSM | RR0816-203-D | VOUT1/VOUT2 $=2.5 \mathrm{~V}$ |
| R3-2 | $150 \mathrm{k} \Omega$ | SSM | RR0816-154-D |  |
| R4 | $300 \mathrm{k} \Omega$ | SSM | RR0816-304-D |  |
| R5 | $510 \mathrm{k} \Omega$ | KOA | RK73G1JTTD D 510 k $\Omega$ |  |
| R6 | $100 \mathrm{k} \Omega$ | SSM | RR0816-104-D |  |
| C1 | $4.7 \mu \mathrm{~F}$ | TDK | C2012JB1A475K |  |
| C2 | $4.7 \mu \mathrm{~F}$ | TDK | C2012JB1A475K |  |
| C3 | $0.1 \mu \mathrm{~F}$ | TDK | C1608JB1E104K |  |
| C6 | $0.1 \mu \mathrm{~F}$ | TDK | C1608JB1H104K | For adjusting slow start time |
| L1 | $2.2 \mu \mathrm{H}$ | TDK | VLF4012AT-2R2M |  |

Note: These components are recommended based on the operating tests authorized.
TDK: TDK Corporation
SSM: SUSUMU Co., Ltd
KOA: KOA Corporation

## 10. Application Notes

### 10.1 Selection of Components

### 10.1.1 Selection of an External Inductor

Basically it dose not need to design inductor. This IC is designed to operate efficiently with a $2.2 \mu \mathrm{H}$ external inductor.
The inductor should be rated for a saturation current higher than the LX peak current value during normal operating conditions, and should have a minimal DC resistance. ( $100 \mathrm{~m} \Omega$ or less is recommended.)
$L X$ peak current value $I_{P K}$ is obtained by the following formula.

$$
I_{\mathrm{PK}}=\mathrm{I}_{\mathrm{OUT}}+\frac{\mathrm{V}_{\mathrm{IN}}-\mathrm{V}_{\mathrm{OUT}}}{\mathrm{~L}} \times \frac{\mathrm{D}}{\text { fosc }} \times \frac{1}{2}=\mathrm{I}_{\mathrm{OUT}}+\frac{\left(\mathrm{V}_{\text {IN }}-V_{\mathrm{OUT}}\right) \times \mathrm{V}_{\mathrm{OUT}}}{2 \infty \mathrm{~L} \infty \text { fosc } \times \mathrm{V}_{\mathrm{IN}}}
$$

L : External inductor value
IOUT : Load current
$\mathrm{V}_{\mathrm{IN}}$ : Power supply voltage
$V_{\text {OUT }}$ : Output setting voltage
D: ON-duty to be switched ( $=\mathrm{V}_{\mathrm{OUT}} / \mathrm{V}_{\text {IN }}$ )
fosc : Switching frequency (2.0 MHz)
For Example:
When $\mathrm{V}_{\text {IN }}=3.7 \mathrm{~V}, \mathrm{~V}_{\text {OUT }}=2.5 \mathrm{~V}, \mathrm{I}_{\text {OUT }}=0.8 \mathrm{~A}, \mathrm{~L}=2.2 \mu \mathrm{H}$, fosc $=2.0 \mathrm{MHz}$
The maximum peak current value $\mathrm{l}_{\mathrm{PK}}$ is obtained by the following formula.

$$
\mathrm{I}_{\mathrm{PK}}=\mathrm{I}_{\mathrm{OUT}}+\frac{\left(\mathrm{V}_{\mathrm{IN}}-\mathrm{V}_{\mathrm{OUT}}\right) \times \mathrm{V}_{\mathrm{OUT}}}{2 \times \mathrm{L} \times \text { fosc } \times \mathrm{V}_{\mathrm{IN}}}=0.8 \mathrm{~A}+\frac{(3.7 \mathrm{~V}-2.5 \mathrm{~V}) \times 2.5 \mathrm{~V}}{2 \times 2.2 \mu \mathrm{H} \times 2.0 \mathrm{MHz} \times 3.7 \mathrm{~V}} \approx 0.89 \mathrm{~A}
$$

### 10.1.2 I/O Capacitor Selection

■ Select a low equivalent series resistance (ESR) for the VDD input capacitor to suppress dissipation from ripple currents.

- Also select a low equivalent series resistance (ESR) for the output capacitor. The variation in the inductor current causes ripple currents on the output capacitor which, in turn, causes ripple voltages an output equal to the amount of variation multiplied by the ESR value. The output capacitor value has a significant impact on the operating stability of the device when used as a DC/DC converter. Therefore, Cypress Semiconductor generally recommends a $4.7 \mu \mathrm{~F}$ capacitor, or a larger capacitor value can be used if ripple voltages are not suitable. If the $\mathrm{V}_{\text {IN }} / \mathrm{V}_{\text {OUT }}$ voltage difference is within 0.6 V , the use of a $10 \mu \mathrm{~F}$ output capacitor value is recommended.
- Types of capacitors

Ceramic capacitors are effective for reducing the ESR and afford smaller DC/DC converter circuit. However, power supply functions as a heat generator, therefore avoid to use capacitor with the F-temperature rating ( $-80 \%$ to $+20 \%$ ). Cypress Semiconductor recommends capacitors with the B-temperature rating ( $\pm 10 \%$ to $\pm 20 \%$ ). Normal electrolytic capacitors are not recommended due to their high ESR.
Tantalum capacitor will reduce ESR, however, it is dangerous to use because it turns into short mode when damaged. If you insist on using a tantalum capacitor, Cypress Semiconductor recommends the type with an internal fuse.

### 10.2 Output Voltage Setting

The output voltage $\mathrm{V}_{\text {OUT }}\left(\mathrm{V}_{\text {OUT1 }}\right.$ or $\mathrm{V}_{\text {OUT2 }}$ ) of this IC is defined by the voltage input to VREFIN (VREFIN1 or VREFIN2). Supply the voltage for inputting to VREFIN from an external power supply, or set the VREF output by dividing it with resistors.
The output voltage when the VREFIN voltage is set by dividing the VREF voltage with resistors is obtained by the following formula.

$$
\begin{aligned}
& \mathrm{V}_{\mathrm{OUT}}=2.97 \times \mathrm{V}_{\text {REFIN }}, \quad \mathrm{V}_{\text {REFIN }}=\frac{\mathrm{R} 2}{\mathrm{R} 1+\mathrm{R} 2} \times \mathrm{V}_{\mathrm{REF}} \\
& \quad\left(\mathrm{~V}_{\mathrm{REF}}=1.30 \mathrm{~V}\right)
\end{aligned}
$$



Note : Refer to " Application Circuit Examples" for the an example of this circuit.
Although the output voltage is defined according to the dividing ratio of resistance, select the resistance value so that the current flowing through the resistance does not exceed the VREF current rating (1 mA) .

### 10.3 About Conversion Efficiency

The conversion efficiency can be improved by reducing the loss of the DC/DC converter circuit. The total loss ( $\mathrm{P}_{\text {LOSS }}$ ) of the DC/DC converter is roughly divided as follows :

```
P
    P
        for internal SW FETs)
    PSW : Switching loss (The loss caused during switching of the IC's internal SW FETs)
    P
        external circuits )
```

The IC's control circuit loss ( $\mathrm{P}_{\mathrm{CONT}}$ ) is extremely small, less than $100 \mathrm{~mW}^{*}$ (with no load).
As the IC contains FETs which can switch faster with less power, the continuity loss $\left(\mathrm{P}_{\mathrm{C}}\right)$ is more predominant as the loss during heavy-load operation than the control circuit loss ( $\mathrm{P}_{\text {CONT }}$ ) and switching loss ( $\mathrm{P}_{\mathrm{SW}}$ ) .
Furthermore, the continuity loss $\left(\mathrm{P}_{\mathrm{C}}\right)$ is divided roughly into the loss by internal SW FET ON-resistance and by external inductor series resistance.

$$
\begin{array}{cl}
\mathrm{P}_{\mathrm{C}}=\mathrm{I}_{\mathrm{OUT}}{ }^{2} \times\left(\mathrm{RDC}+\mathrm{D} \times \mathrm{R}_{\mathrm{ONP}}+(1-\mathrm{D}) \times \mathrm{R}_{\mathrm{ONN}}\right) \\
\mathrm{D} & : \text { Switching ON-duty cycle }\left(=\mathrm{V}_{\mathrm{OUT}} / \mathrm{V}_{\mathrm{IN}}\right) \\
\mathrm{R}_{\mathrm{ONP}} & : \text { Internal P-ch SW FET ON resistance } \\
\mathrm{R}_{\mathrm{ONN}} & : \text { Internal N-ch SW FET ON resistance } \\
\mathrm{RDC} & : \text { External inductor series resistance } \\
\mathrm{I}_{\mathrm{OUT}} & : \text { Load current }
\end{array}
$$

The above formula indicates that it is important to reduce RDC as much as possible to improve efficiency by selecting components.

* : The loss in the successive operation mode. This IC suppresses the loss in order to execute the PFM operation in the low load mode (less than $100 \mu \mathrm{~A}$ in no load mode). Mode is changed by the current peak value $\mathrm{I}_{\mathrm{PK}}$ which flows into switching FET. The threshold value is about 30 mA .


### 10.4 Power Dissipation and Heat Considerations

The IC is so efficient that no consideration is required in most cases. However, if the IC is used at a low power supply voltage, heavy load, high output voltage, or high temperature, it requires further consideration for higher efficiency.
The internal loss $(P)$ is roughly obtained from the following formula:

$$
\begin{aligned}
& P=I_{O U T}{ }^{2} \times\left(\mathrm{D} \times \mathrm{R}_{\mathrm{ONP}}+(1-\mathrm{D}) \times \mathrm{R}_{\mathrm{ONN}}\right) \\
& \mathrm{D} \\
& \mathrm{R}_{\mathrm{ONP}}: \text { Switching ON-duty cycle }\left(=\mathrm{V}_{\mathrm{OUT}} / \mathrm{V}_{\mathrm{IN}}\right) \\
& \mathrm{R}_{\mathrm{ONN}} \\
& \mathrm{I}_{\mathrm{OUT}}: \text { Internal P-ch SW FET ON resistance } \\
& \text { : Output current }
\end{aligned}
$$

The loss expressed by the above formula is mainly continuity loss. The internal loss includes the switching loss and the control circuit loss as well but they are so small compared to the continuity loss they can be ignored.
In this IC with $\mathrm{R}_{\mathrm{ONP}}$ greater than $\mathrm{R}_{\mathrm{ONN}}$, the larger the on-duty cycle, the greater the loss.
When assuming $\mathrm{V}_{\mathrm{IN}}=3.7 \mathrm{~V}, \mathrm{Ta}=+70^{\circ} \mathrm{C}$, for example, $\mathrm{R}_{\mathrm{ONP}}=0.36 \Omega$ and $\mathrm{R}_{\mathrm{ONN}}=0.30 \Omega$ according to the graph "MOS FET ON" resistance vs. Operating ambient temperature". The IC's internal loss P is 123 mW at
$\mathrm{V}_{\text {OUT }}=2.5 \mathrm{~V}$ and $\mathrm{I}_{\text {OUT }}=0.6 \mathrm{~A}$. According to the graph "Power dissipation vs. Operating ambient temperature", the power dissipation at an operating ambient temperature Ta of $+70^{\circ} \mathrm{C}$ is 300 mW and the internal loss is smaller than the power dissipation.

### 10.5 XPOR Threshold Voltage Setting [ $\mathrm{V}_{\text {PORH }}, \mathrm{V}_{\text {PORL }}$ ]

Set the detection voltage by applying voltage to the VDET pin via an external resistor calculated according to this formula.

$$
\begin{aligned}
\mathrm{V}_{\mathrm{PORH}} & =\frac{\mathrm{R} 3+\mathrm{R} 4}{\mathrm{R} 4} \times \mathrm{V}_{\mathrm{THHPR}} \\
\mathrm{~V}_{\mathrm{PORL}} & =\frac{\mathrm{R} 3+\mathrm{R} 4}{\mathrm{R} 4} \times \mathrm{V}_{\text {THLPR }} \\
\mathrm{V}_{\text {THHPR }} & =0.600 \mathrm{~V} \\
\mathrm{~V}_{\text {THLPR }} & =0.583 \mathrm{~V}
\end{aligned}
$$

■ Example for setting detection voltage to 3.7 V

$$
\begin{aligned}
\mathrm{R} 3 & =510 \mathrm{k} \Omega \\
\mathrm{R} 4 & =100 \mathrm{k} \Omega \\
\mathrm{~V}_{\mathrm{PORH}} & =\frac{510 \mathrm{k} \Omega+100 \mathrm{k} \Omega}{100 \mathrm{k} \Omega} \times 0.600=3.66 \approx 3.7[\mathrm{~V}] \\
\mathrm{V}_{\mathrm{PORL}} & =\frac{510 \mathrm{k} \Omega+100 \mathrm{k} \Omega}{100 \mathrm{k} \Omega} \times 0.583=3.56 \approx 3.6[\mathrm{~V}]
\end{aligned}
$$



### 10.6 Transient Response

Normally, I $\mathrm{I}_{\mathrm{OUT}}$ is suddenly changed while $\mathrm{V}_{\mathrm{IN}}$ and $\mathrm{V}_{\text {OUT }}$ are maintained constant, responsiveness including the response time and overshoot/undershoot voltage is checked. As this IC has built-in Error Amp with an optimized design, it shows good transient response characteristics. However, if ringing upon sudden change of the load is high due to the operating conditions, add capacitor C 6 (For exmple. $0.1 \mu \mathrm{~F}$ ). (Since this capacitor C 6 changes the start time, check the start waveform as well.) This action is not required for DAC input.


### 10.7 Board Layout, Design Example

The board layout needs to be designed to ensure the stable operation of this IC.
Follow the procedure below for designing the layout.

- Arrange the input capacitor (Cin) as close as possible to both the VDD and GND pins. Make a through-hole (TH) near the pins of this capacitor if the board has planes for power and GND.
- Large AC currents flow between this IC and the input capacitor (Cin), output capacitor (Co), and external inductor (L). Group these components as close as possible to this IC to reduce the overall loop area occupied by this group. Also try to mount these components on the same surface and arrange wiring without through-hole wiring. Use thick, short, and straight routes to wire the net (The layout by planes is recommended.).
■ Arrange a bypass capacitor for AVDD as close as possible to both the AVDD and AGND pins. Make a through-hole (TH) near the pins of this capacitor if the board has planes for power and GND.
- The feedback wiring to the OUT should be wired from the voltage output pin closest to the output capacitor (Co). The OUT pin is extremely sensitive and should thus be kept wired away from the LX1 pin and LX2 pin of this IC as far as possible.
■ If applying voltage to the VREFIN1/VREFIN2 pins through dividing resistors, arrange the resistors so that the wiring can be kept as short as possible. Also arrange them so that the GND pin of VREFIN1/VREFIN2 resistor is close to the IC's AGND pin. Further, provide a GND exclusively for the control line so that the resistor can be connected via a path that does not carry current. If installing a bypass capacitor for the VREFIN, put it close to the VREFIN pin.
- If applying voltage to the VDET pin through dividing resistors, arrange the resistors so that the wiring can be kept as short as possible. Also arrange so that the GND pin of the VDET resistor is close to the IC's AGND pin. Further, provide a GND exclusively for the control line so that the resistor can be connected via a path that does not carry current.

■ Try to make a GND plane on the surface to which this IC will be mounted. For efficient heat dissipation when using the QFN-24 package, Cypress Semiconductor recommends providing a thermal via in the footprint of the thermal pad.

Example of arranging IC SW system parts


### 10.7.1 Notes for Circuit Design

The switching operation of this IC works by monitoring and controlling the peak current which, incidentally, serves as a form of short-circuit protection. However, do not leave the output short-circuited for long periods of time. If the output is short-circuited where $\mathrm{V}_{\mathrm{IN}}<2.9 \mathrm{~V}$, the current limit value (peak current to the inductor) tends to rise. Leaving in the short-circuit state, the temperature of this IC will continue rising and activate the thermal protection.
Once the thermal protection stops the output, the temperature of the IC will go down and operation will be restarted, after which the output will repeat the starting and stopping.Although this effect will not destroy the IC, the thermal exposure to the IC over prolonged hours may affect the peripherals surrounding it.

## 11. Example of Standard Operation Characteristics

(Following is an example of characteristics for connection according to "Test Circuit for Measuring Typical Operating Characteristics".)

### 11.1 Characteristics CH1



MB39C007








### 11.2 Switching Waveform



### 11.3 Output Waveforms at Sudden Load Changes



### 11.4 CTL Start-up Waveform

No load, No VREFIN capacitor

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{~V} 01=2.5 \mathrm{~V}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$
Maximum load, No VREFIN capacitor

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{~V} 01=2.5 \mathrm{~V}, \mathrm{IO}=-800 \mathrm{~mA}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{VO}=1.8 \mathrm{~V}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{VO2}=1.8 \mathrm{~V}, \mathrm{IO} 2=-800 \mathrm{~mA}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$

No load, VREFIN capacitor $=0.1 \mu \mathrm{~F}$


Maximum load, VREFIN capacitor $=0.1 \mu \mathrm{~F}$

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{VO1}=2.5 \mathrm{~V}, \mathrm{IO}=-800 \mathrm{~mA}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$


### 11.5 CTL Stop Waveform

Maximum load, VREFIN capacitor $=0.1 \mu \mathrm{~F}$

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{VO} 1=2.5 \mathrm{~V}, \mathrm{IO} 1=-800 \mathrm{~mA}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$

$\mathrm{VIN}=3.7 \mathrm{~V}, \mathrm{Vo2}=1.8 \mathrm{~V}, \mathrm{IO} 2=-800 \mathrm{~mA}, \mathrm{MODE}=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$

### 11.6 Current Limitation Waveform



### 11.7 Voltage Detection Waveform



### 11.8 Waveform of Dynamic Output Voltage Transition ( $\mathrm{V}_{\mathrm{O} 1} 1.8 \mathrm{~V} \longleftrightarrow 2.5 \mathrm{~V}$ )


$\mathrm{Vin}=3.7 \mathrm{~V}$, lo1 $=-800 \mathrm{~mA},-576 \mathrm{~mA}(3.125 \Omega)$, MODE $=\mathrm{L}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$, No VREFIN capacitor

## 12. Application Circuit Examples

### 12.1 Application Circuit Example 1

An external voltage is input to the reference voltage external input (VREFIN1, VREFIN2), and the $\mathrm{V}_{\text {OUT }}$ voltage is set to 2.97 times the $\mathrm{V}_{\text {OUT }}$ setting gain.


### 12.2 Application Circuit Example 2

The voltage of VREF pin is input to the reference voltage external input (VREFIN1, VREFIN2) by dividing resistors. The $\mathrm{V}_{\text {OUT1 }}$ voltage is set to 2.5 V and $\mathrm{V}_{\text {OUT2 }}$ voltage is set to 1.8 V .


### 12.3 Application Circuit Example Components List

| Component | Item | Part Number | Specification | Package | Vendor |
| :---: | :--- | :--- | :--- | :--- | :--- |
| L1 | Inductor | VLF4012AT-2R2M | $2.2 \mu \mathrm{H}, \mathrm{RDC}=76 \mathrm{~m} \Omega$ | SMD | TDK |
|  |  | MIPW3226D2R2M | $2.2 \mu \mathrm{H}, \mathrm{RDC}=100 \mathrm{~m} \Omega$ | SMD | FDK |
| L2 | Inductor | VLF4012AT-2R2M | $2.2 \mu \mathrm{H}, \mathrm{RDC}=76 \mathrm{~m} \Omega$ | SMD | TDK |
|  |  | MIPW3226D2R2M | $2.2 \mu \mathrm{H}, \mathrm{RDC}=100 \mathrm{~m} \Omega$ | SMD | FDK |
| C1 | Ceramic capacitor | C2012JB1A475K | $4.7 \mu \mathrm{~F}(10 \mathrm{~V})$ | 2012 | TDK |
| C2 | Ceramic capacitor | C2012JB1A475K | $4.7 \mu \mathrm{~F}(10 \mathrm{~V})$ | 2012 | TDK |
| C3 | Ceramic capacitor | C2012JB1A475K | $4.7 \mu \mathrm{~F}(10 \mathrm{~V})$ | 2012 | TDK |
| C4 | Ceramic capacitor | C2012JB1A475K | $4.7 \mu \mathrm{~F}(10 \mathrm{~V})$ | 2012 | TDK |
| C5 | Ceramic capacitor | C1608JB1E104K | $0.1 \mu \mathrm{~F}(50 \mathrm{~V})$ | 2012 | TDK |
| R1 | Resistor | RK73G1JTTD D $13 \mathrm{k} \Omega$ <br> RK73G1JTTD D $150 \mathrm{k} \Omega$ | $13 \mathrm{k} \Omega$ | $150 \mathrm{k} \Omega$ | 1608 |
|  | Resistor | RK73G1JTTD D $300 \mathrm{k} \Omega$ | $300 \mathrm{k} \Omega$ | 1608 | KOA |
| R5 | Resistor | RK73G1JTTD D $13 \mathrm{k} \Omega$ <br> RK73G1JTTD D $330 \mathrm{k} \Omega$ | $13 \mathrm{k} \Omega$ | $330 \mathrm{k} \Omega$ | 1608 |
|  | Resistor | RK73G1JTTD D $300 \mathrm{k} \Omega$ | $300 \mathrm{k} \Omega$ | 1608 | KOA |
| R7 | Resistor | RK73G1JTTD D $1 \mathrm{M} \Omega$ | $1 \mathrm{M} \Omega \pm 0.5 \%$ | 1608 | KOA |
| R8 | Resistor | RK73G1JTTD D $1 \mathrm{M} \Omega$ | $1 \mathrm{M} \Omega \pm 0.5 \%$ | 1608 | KOA |
|  |  |  | 1608 | KOA |  |

TDK : TDK Corporation
FDK : FDK Corporation
KOA : KOA Corporation

## 13. Usage Precautions

## 1. Do not configure the IC over the Maximum Ratings

If the IC is used over the maximum ratings, the LSI may be permanently damaged.It is preferable for the device to normally operate within the recommended usage conditions. Usage outside of these conditions adversely affect the reliability of the LSI.
2. Use the devices within recommended operating conditions

The recommended operating conditions are the conditions under which the LSI is guaranteed to operate. The electrical ratings are guaranteed when the device is used within the recommended operating conditions and under the conditions stated for each item.
3. Printed circuit board ground lines should be set up with consideration for common impedance
4. Take appropriate static electricity measures

- Containers for semiconductor materials should have anti-static protection or be made of conductive material.
- After mounting, printed circuit boards should be stored and shipped in conductive bags or containers.
- Work platforms, tools, and instruments should be properly grounded.
- Working personnel should be grounded with resistance of $250 \mathrm{k} \Omega$ to $1 \mathrm{M} \Omega$ between body and ground.

5. Do not apply negative voltages

The use of negative voltages below -0.3 V may create parasitic transistors on LSI lines, which can cause abnormal operation.

## 14. Ordering Information

| Part number | Package | Remarks |
| :---: | :---: | :---: |
| MB39C007WQN | 24-pin plastic QFN <br> (WNNO24) | - |

## 15. RoHS Compliance Information

The LSI products of Cypress Semiconductor with "E1" are compliant with RoHS Directive, and has observed the standard of lead, cadmium, mercury, hexavalent chromium, polybrominated biphenyls (PBB) , and polybrominated diphenyl ethers (PBDE).
A product whose part number has trailing characters "E1" is RoHS compliant.

## 16. Package Dimension

Package Code: WNNO24

SIDE VIEW

| SYMBOL | DIMENSIONS |  |  |
| :---: | :---: | :---: | :---: |
|  | MIN. | NOM. | MAX. |
| A | - | - | 0.80 |
| A1 | 0.00 | - | 0.05 |
| D | 4.00 BSC |  |  |
| E | 4.00 BSC |  |  |
| b | 0.20 | 0.25 | 0.30 |
| D2 | 2.60 BSC |  |  |
| E2 | 2.60 BSC |  |  |
| e | 0.50 BSC |  |  |
| c | 0.35 REF |  |  |
| L | 0.35 | 0.40 | 0.45 |

NOTE

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCINC CONFORMS TO ASME Y14.5-1994.
3. N IS THE TOTAL NUMBER OF TERMINALS.
4. DIMENSION "b" APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.IF THE TERMINAL HAS THE OPTIONAL RADIUS ON THE OTHER END OF THE TERMINAL. THE DIMENSION "b"SHOULD NOT BE MEASURED IN THAT RADIUS AREA.
© ND REFER TO THE NUMBER OF TERMINALS ON D OR E SIDE.
5. MAX. PACKAGE WARPAGE IS 0.05 mm .
6. MAXIMUM ALLOWABLE BURRS IS 0.076 mm IN ALL DIRECTIONS.
7. PIN \#1 ID ON TOP WILL BE LOCATED WITHIN INDICATED ZONE.
Qิ BILATERAL COPLANARITY ZONE APPLIES TO THE EXPOSED HEAT SINK SLUG AS WELL AS THE TERMINALS
8. JEDEC SPECIFICATION NO. REF : N/A

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| *C | 5756336 | MASG | $05 / 31 / 2017$ | Updated to Cypress template |  |  |

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LTC3644IY\#PBF LD8116CGL HG2269M/TR OB2269 XD3526 U6215A U6215B U6620S LTC3803ES6\#TR LTC3803ES6\#TRM
LTC3412IFE LT1425IS MAX25203BATJA/VY+ MAX77874CEWM + XC9236D08CER-G ISL95338IRTZ MP3416GJ-P BD9S201NUXCE2 MP5461GC-Z MPQ4415AGQB-Z MPQ4590GS-Z LX7178-01CSP-TR MCP1642B-18IMC MCP1642D-ADJIMC MCP1642D-18IMC MCP1642D-30IMC MCP1665T-E/MRA MIC2876-4.75YMT-T5


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